TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

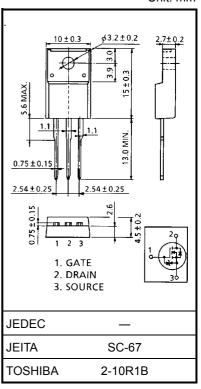
2SK2350

Switching Regulator, DC–DC Converter and Motor Drive Applications

- 4 V gate drive
- Low drain-source ON resistance $: R_{DS} (ON) = 0.26 \Omega (typ.)$
- High forward transfer admittance $|Y_{fs}| = 8 S (typ.)$
- Low leakage current $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 200 \ V)$
- Enhancement-mode : $V_{th} = 1.5 \sim 3.5 V (V_{DS} = 10 V, I_D = 1 mA)$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	200	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	200	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	8.5	А	
	Pulse (Note 1)	I _{DP}	34	А	
Drain power dissipatio	n (Tc = 25°C)	PD	30	W	
Single pulse avalanche energy (Note 2)		E _{AS}	110	mJ	
Avalanche current		I _{AR}	8.5	А	
Repetitive avalanche e	energy (Note 3)	E _{AR}	3	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	



Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	4.16	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	62.5	°C / W

Note 1: Please use devices on condition that the channel temperature is below 150°C. Note 2: $V_{DD} = 50 \text{ V}$, $T_{ch} = 25^{\circ}C$ (initial), L = 2.47 mH, $R_G = 25 \Omega$, $I_{AR} = 8.5 \text{ A}$ Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution.

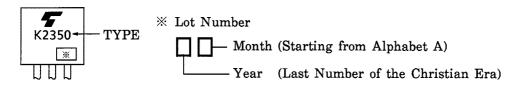
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		_	±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	_	—	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	200	_	_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 5 A	_	0.26	0.4	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 5 A	4	8	_	S
Input capacitance	ce	C _{iss}			700	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		80	_	pF
Output capacitance		C _{oss}			270	—	
Switching time	Rise time	tr	$v_{GS} = 0V$ $v_{GS} = 0V$ $u_{CS} = 0V$ $u_{CS} = 0V$ $u_{CS} = 0V$ $u_{CS} = 100V$	_	15	_	
	Turn-on time	t _{on}		_	25	_	20
	Fall time	t _f		_	15	_	- ns -
	Turn-off time	t _{off}	$V_{DD} = 100V$ Duty $\leq 1\%$, $t_w = 10\mu s$	_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg	V _{DD} ≈ 160 V, V _{GS} = 10 V, I _D = 10 A		17	_	
Gate-source charge		Q _{gs}			10	_	nC
Gate-drain ("miller") charge		Q _{gd}			7	—	

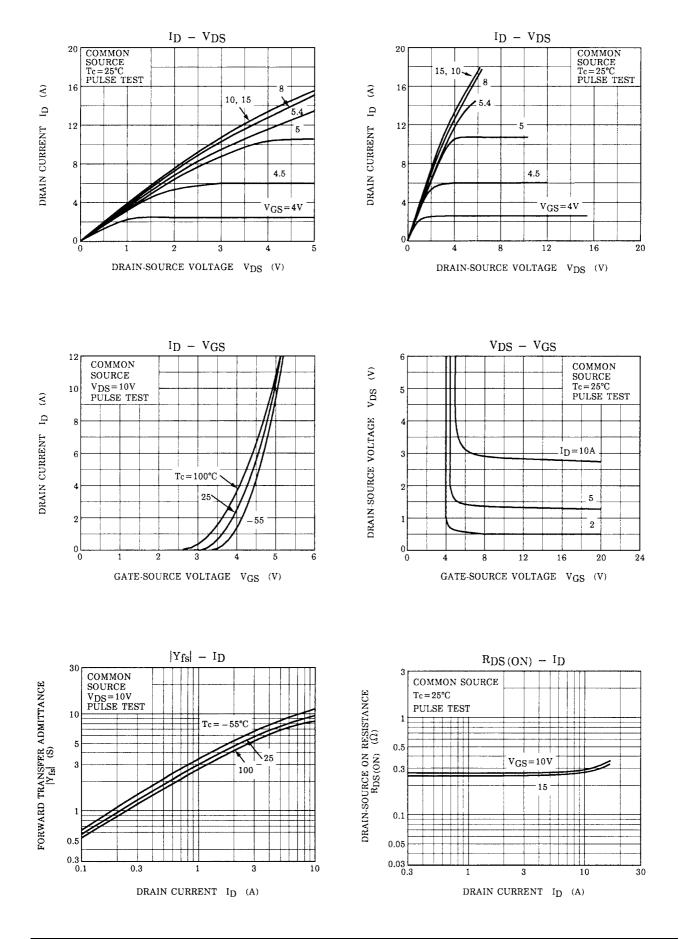
Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	8.5	А
Pulse drain reverse current (Note 1)	I _{DRP}	—	-		34	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 10 A, V _{GS} = 0 V			-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 10 A, V _{GS} = 0 V		155		ns
Reverse recovered charge	Q _{rr}	dI _{DR} / dt = 100 A / µs	_	0.8	_	μC

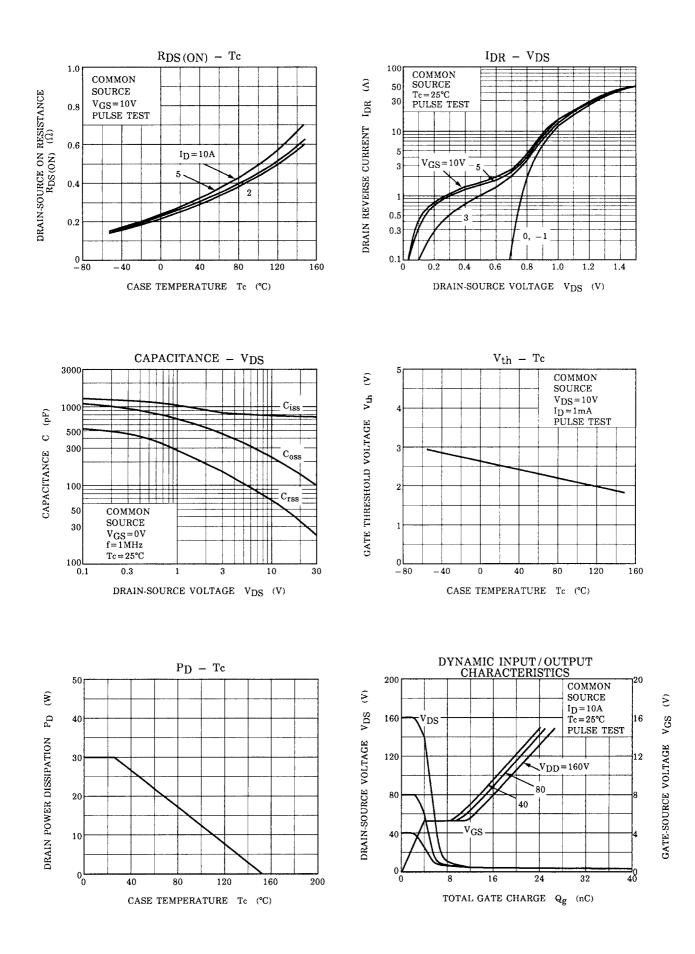
Marking

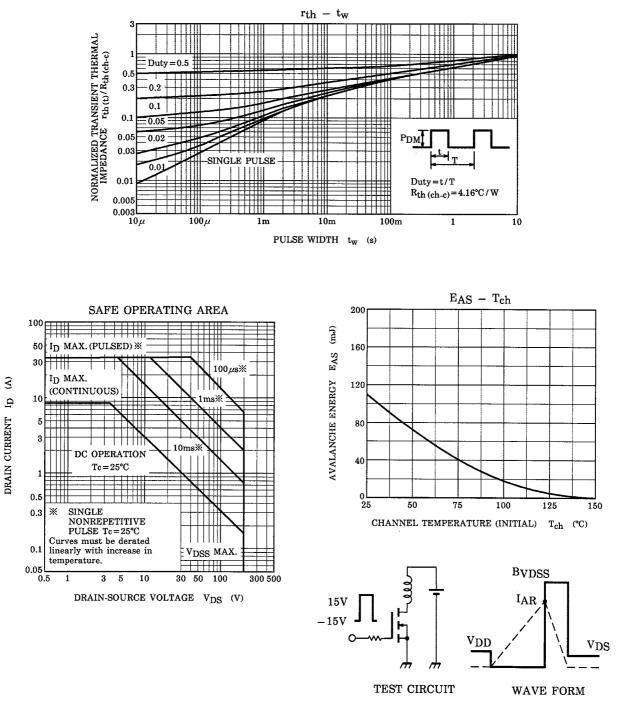


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 $\begin{array}{ll} \mathrm{R_{G}=25~\Omega} \\ \mathrm{V_{DD}=50~V,~L=2.47~mH} \end{array} \quad \quad \mathrm{EAS}=\frac{1}{2}\cdot\mathrm{L}\cdot\mathrm{I}^{2}\cdot\!\left(\frac{\mathrm{BVDSS}}{\mathrm{BVDSS}-\mathrm{VDD}}\right) \\ \end{array}$

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